

# 74LCX32 Low Voltage Quad 2-Input OR Gate with 5V Tolerant Inputs



December 1997

## 74LCX32

### Low Voltage Quad 2-Input OR Gate with 5V Tolerant Inputs

#### General Description

The LCX32 contains four 2-input OR gates. The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

The 74LCX32 is fabricated with advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

#### Features

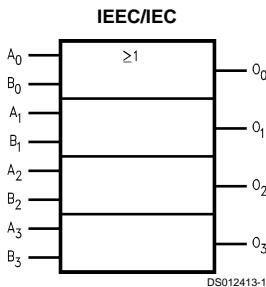
- 5V tolerant inputs
- 5.5 ns  $t_{PD}$  max, 10  $\mu\text{A}$   $I_{CCQ}$  max
- Power down high impedance inputs and outputs
- Supports live insertion/withdrawal
- 2.0V–3.6V  $V_{CC}$  supply operation
- $\pm 24$  mA output drive
- Implements patented noise/EMI reduction circuitry
- Functionally compatible with 74 series 32
- Latch-up performance exceeds 500 mA
- ESD performance:
  - Human body model > 2000V
  - Machine model > 150V

#### Ordering Code:

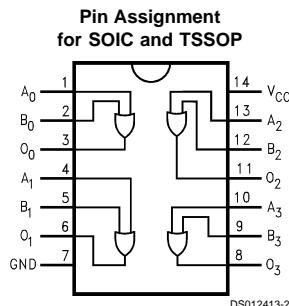
Order Number	Package Number	Package Description
74LCX32M	M14A	14-Lead Small Outline Package, SOIC, JEDEC
74LCX32SJ	M14D	14-Lead, SOIC, EIAJ
74LCX32MTC	MTC14	14-Lead Thin Shrink Small Outline Package, TSSOP

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### Logic Symbol



#### Connection Diagram



#### Pin Descriptions

Pin Names	Description
$A_n, B_n$ $O_n$	Inputs Outputs

### Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Value	Conditions	Units
$V_{CC}$	Supply Voltage	-0.5 to +7.0		V
$V_I$	DC Input Voltage	-0.5 to +7.0		V
$V_O$	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	Output in High or Low State (Note 2)	V
$I_{IK}$	DC Input Diode Current	-50	$V_I < GND$	mA
$I_{OK}$	DC Output Diode Current	-50 +50	$V_O < GND$ $V_O > V_{CC}$	mA
$I_O$	DC Output Source/Sink Current	$\pm 50$		mA
$I_{CC}$	DC Supply Current per Supply Pin	$\pm 100$		mA
$I_{GND}$	DC Ground Current per Ground Pin	$\pm 100$		mA
$T_{STG}$	Storage Temperature	-65 to +150		°C

### Recommended Operating Conditions (Note 3)

Symbol	Parameter	Min	Max	Units
$V_{CC}$	Supply Voltage	Operating	2.0	V
		Data Retention	1.5	
$V_I$	Input Voltage	0	5.5	V
$V_O$	Output Voltage	HIGH or LOW State	0	$V_{CC}$
$I_{OH}/I_{OL}$	Output Current	$V_{CC} = 3.0V - 3.6V$	$\pm 24$	mA
		$V_{CC} = 2.7V$	$\pm 12$	
$T_A$	Free-Air Operating Temperature	-40	85	°C
$\Delta t/\Delta V$	Input Edge Rate, $V_{IN} = 0.8V - 2.0V$ , $V_{CC} = 3.0V$	0	10	ns/V

**Note 1:** The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

**Note 2:**  $I_O$  Absolute Maximum Rating must be observed.

**Note 3:** Unused inputs must be held HIGH or LOW. They may not float.

### DC Electrical Characteristics

Symbol	Parameter	Conditions	$V_{CC}$ (V)	$T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$		Units
				Min	Max	
$V_{IH}$	HIGH Level Input Voltage		2.7–3.6	2.0		V
$V_{IL}$	LOW Level Input Voltage		2.7–3.6		0.8	V
$V_{OH}$	HIGH Level Output Voltage	$I_{OH} = -100 \mu\text{A}$	2.7–3.6	$V_{CC} - 0.2$		V
		$I_{OH} = -12 \text{ mA}$	2.7	2.2		V
		$I_{OH} = -18 \text{ mA}$	3.0	2.4		V
		$I_{OH} = -24 \text{ mA}$	3.0	2.2		V
$V_{OL}$	LOW Level Output Voltage	$I_{OL} = 100 \mu\text{A}$	2.7–3.6		0.2	V
		$I_{OL} = 12 \text{ mA}$	2.7		0.4	V
		$I_{OL} = 16 \text{ mA}$	3.0		0.4	V
		$I_{OL} = 24 \text{ mA}$	3.0		0.55	V
$I_I$	Input Leakage Current	$0 \leq V_I \leq 5.5V$	2.7–3.6		$\pm 5.0$	$\mu\text{A}$
$I_{OFF}$	Power-Off Leakage Current	$V_I$ or $V_O = 5.5V$	0		10	$\mu\text{A}$
$I_{CC}$	Quiescent Supply Current	$V_I = V_{CC}$ or GND	2.7–3.6		10	$\mu\text{A}$
		$3.6V \leq V_I \leq 5.5V$	2.7–3.6		$\pm 10$	$\mu\text{A}$
$\Delta I_{CC}$	Increase in $I_{CC}$ per Input	$V_{IH} = V_{CC} - 0.6V$	2.7–3.6		500	$\mu\text{A}$

## AC Electrical Characteristics

Symbol	Parameter	$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$ , $C_L = 50\text{pF}$ , $R_L = 500\Omega$				Units	
		$V_{CC} = 3.3V \pm 0.3V$		$V_{CC} = 2.7V$			
		Min	Max	Min	Max		
$t_{PHL}$	Propagation Delay	1.5	5.5	1.5	6.2	ns	
$t_{PLH}$		1.5	5.5	1.5	6.2		
$t_{OSHL}$	Output to Output		1.0			ns	
$t_{OSLH}$	Skew (Note 4)		1.0				

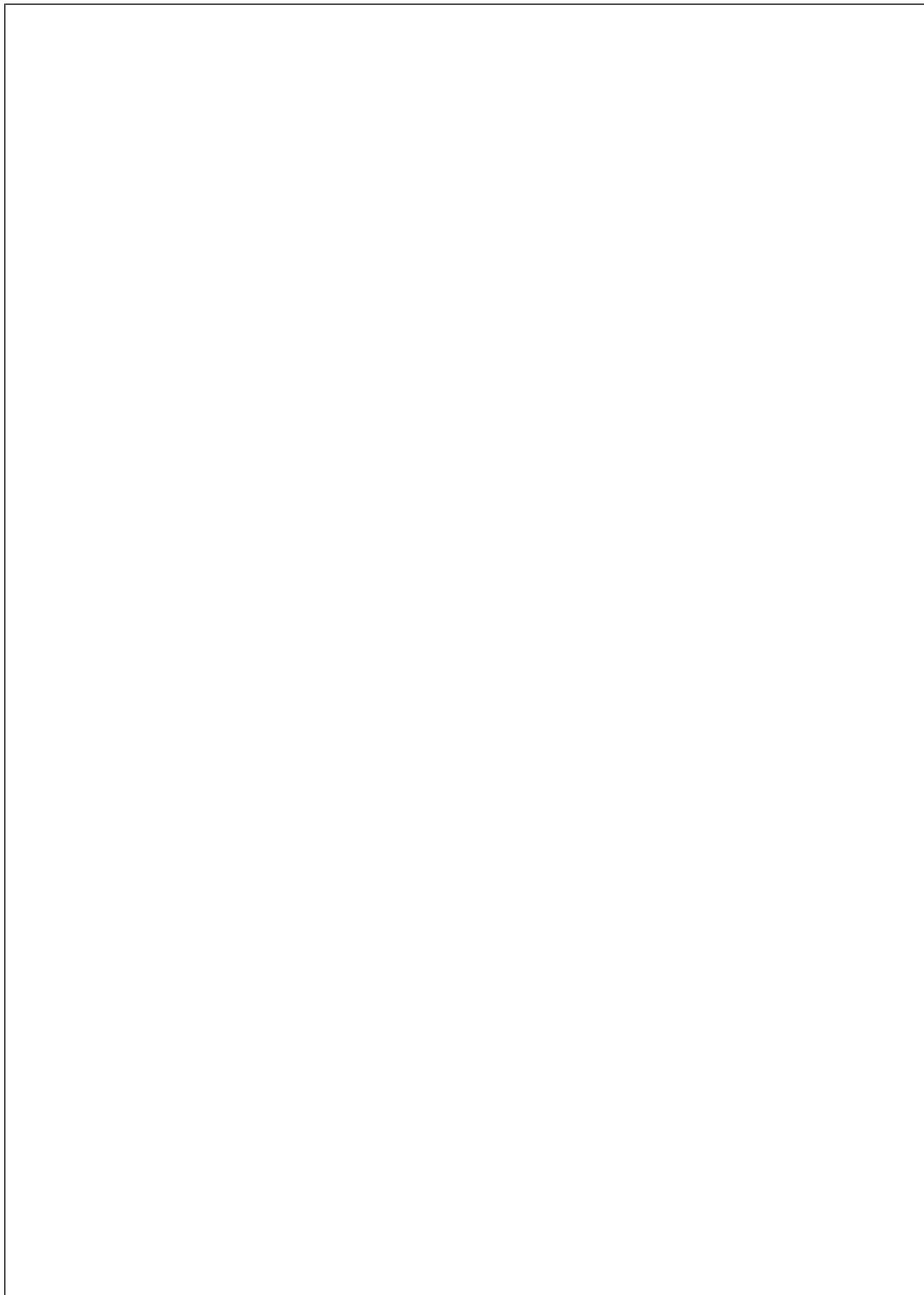
**Note 4:** Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW ( $t_{OSHL}$ ) or LOW to HIGH ( $t_{OSLH}$ ).

## Dynamic Switching Characteristics

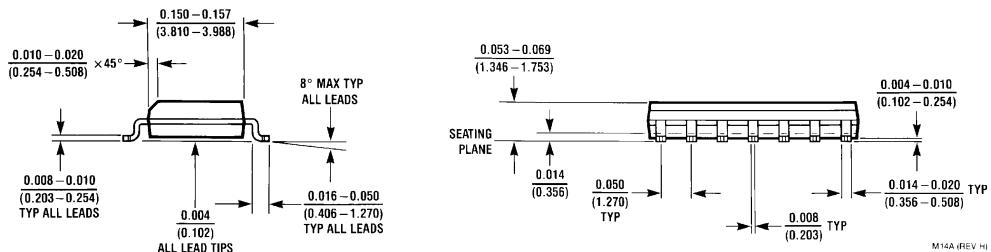
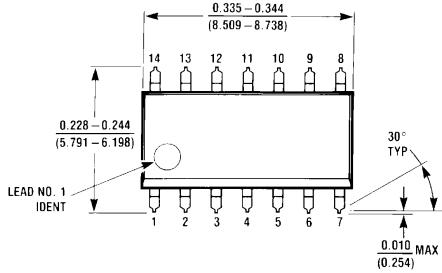
Symbol	Parameter	Conditions	$V_{CC}$ (V)	$T_A = 25^\circ\text{C}$	Unit
				Typical	
$V_{OLP}$	Quiet Output Dynamic Peak $V_{OL}$	$C_L = 50\text{ pF}$ , $V_{IH} = 3.3V$ , $V_{IL} = 0V$	3.3	0.8	V
$V_{OLV}$	Quiet Output Dynamic Valley $V_{OL}$	$C_L = 50\text{ pF}$ , $V_{IH} = 3.3V$ , $V_{IL} = 0V$	3.3	-0.8	V

## Capacitance

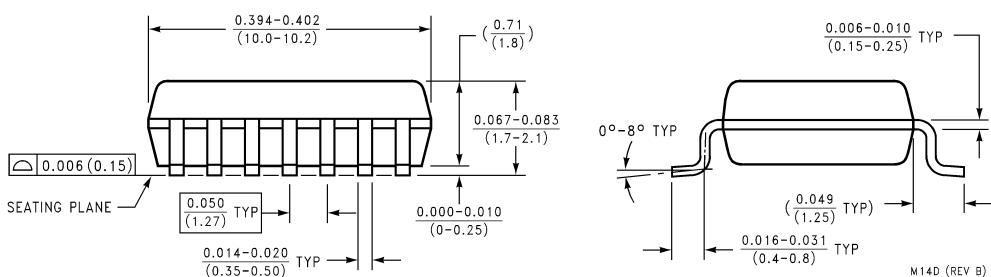
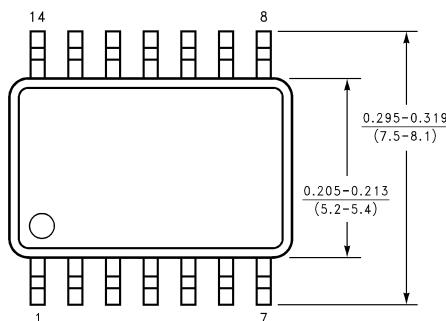
Symbol	Parameter	Conditions	Typical	Units
$C_{IN}$	Input Capacitance	$V_{CC}$ = Open, $V_i = 0V$ or $V_{CC}$	7	pF
$C_{OUT}$	Output Capacitance	$V_{CC} = 3.3V$ , $V_i = 0V$ or $V_{CC}$	8	pF
$C_{PD}$	Power Dissipation Capacitance	$V_{CC} = 3.3V$ , $V_i = 0V$ or $V_{CC}$ , $f = 10\text{ MHz}$	25	pF



**Physical Dimensions** inches (millimeters) unless otherwise noted



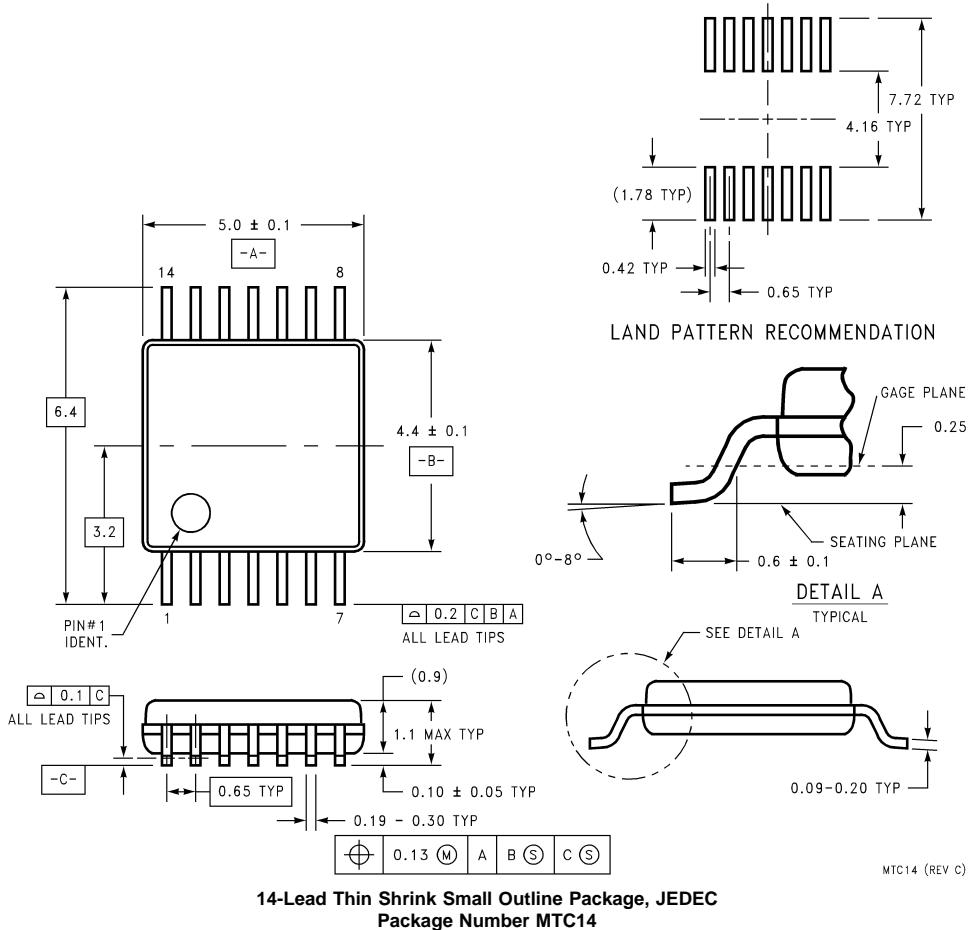
14-Lead Small Outline Package JEDEC (M)  
Package Number M14A



14-Lead Molded Small Outline Package EIAJ  
Package Number M14D

## 74LCX32 Low Voltage Quad 2-Input OR Gate with 5V Tolerant Inputs

### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Thin Shrink Small Outline Package, JEDEC  
Package Number MTC14

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Fairchild Semiconductor  
Europe  
Fax: +49 (0) 1 80-530 85 86  
Email: europe.support@nsc.com  
Deutsch Tel: +49 (0) 8 141-35-0  
English Tel: +44 (0) 1 793-85-68-56  
Italy Tel: +39 (0) 2 57 5631

Fairchild Semiconductor  
Hong Kong Ltd.  
13th Floor, Straight Block,  
Ocean Centre, 5 Canton Rd.  
Tsimshatsui, Kowloon  
Hong Kong  
Tel: +852 2737-7200  
Fax: +852 2314-0061

National Semiconductor  
Japan Ltd.  
Tel: 81-3-5620-6175  
Fax: 81-3-5620-6179